

Search Notes

Application/Control No.

10/644,346

Examiner

Allahyar Kasraian

Applicant(s)/Patent under
Reexamination

JIANG ET AL.

Art Unit

2617

SEARCHED

Class	Subclass	Date	Examiner
370	462	7/5/2007	AK
370	230	7/5/2007	AK

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST Image and keyword search in USPTO, US-PGPUB, DERWENT, EPO, JPO, and IBM_TDB (see attached search strategy)	7/5/2007	AK
Inventor name and Assignee search in PALM ExPo and EAST	7/5/2007	AK
((370/462,431,432,437,442- 444,458,461,401,321,337,347,345,31 0,389.ccls.) (719/311.ccls.) (340/3.1,3.21.ccls.) (710/45,40,36.c	7/5/2007	AK
IEEE Xplore <a href="http://ieeexplore.ieee.org/Xplore/DynW
el.jsp">http://ieeexplore.ieee.org/Xplore/DynW el.jsp Google http://www.google.com	7/5/2007	AK
EPO Data base http://ep.espacenet.com	7/5/2007	AK
PLUS search	7/5/2007	AK
Updated search	1/25/2008	AK